



# Next-generation Battery Materials

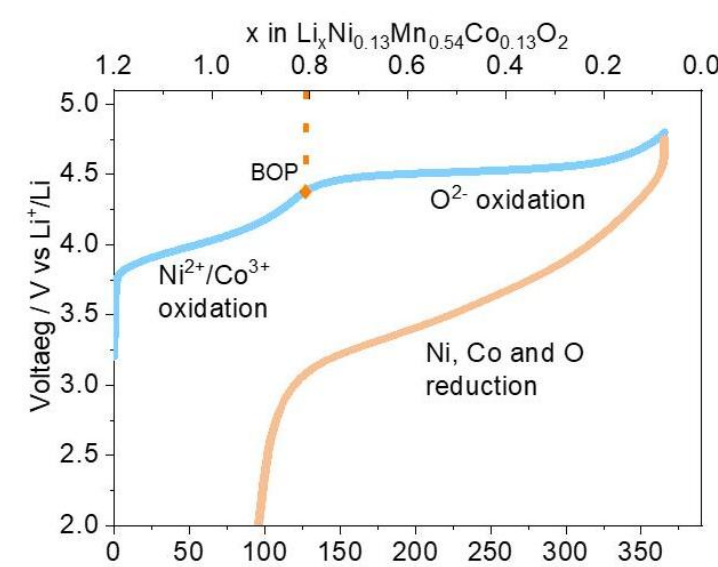
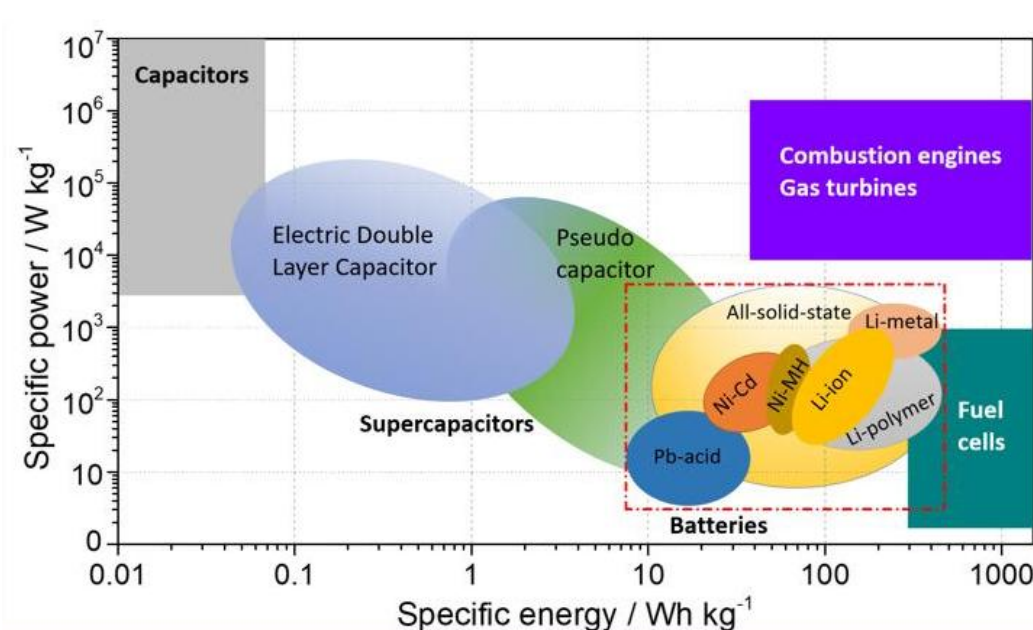
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## Research Summary

Our research aims to develop next-generation energy storage and conversion materials to enable technologies addressing energy and climate challenges.

We are particularly interested in battery materials, such as layered metal oxides and polyanion cathodes. Anionic-redox layered oxides, such as  $\text{Li}_{1.2}[\text{Ni}_{0.13}\text{Mn}_{0.54}\text{Co}_{0.13}]\text{O}_2$  are considered the next-generation cathodes with capacities beyond  $250 \text{ mAh g}^{-1}$  resulting from the cationic and anionic ( $\text{O}^{2-}$ ) redox reaction.

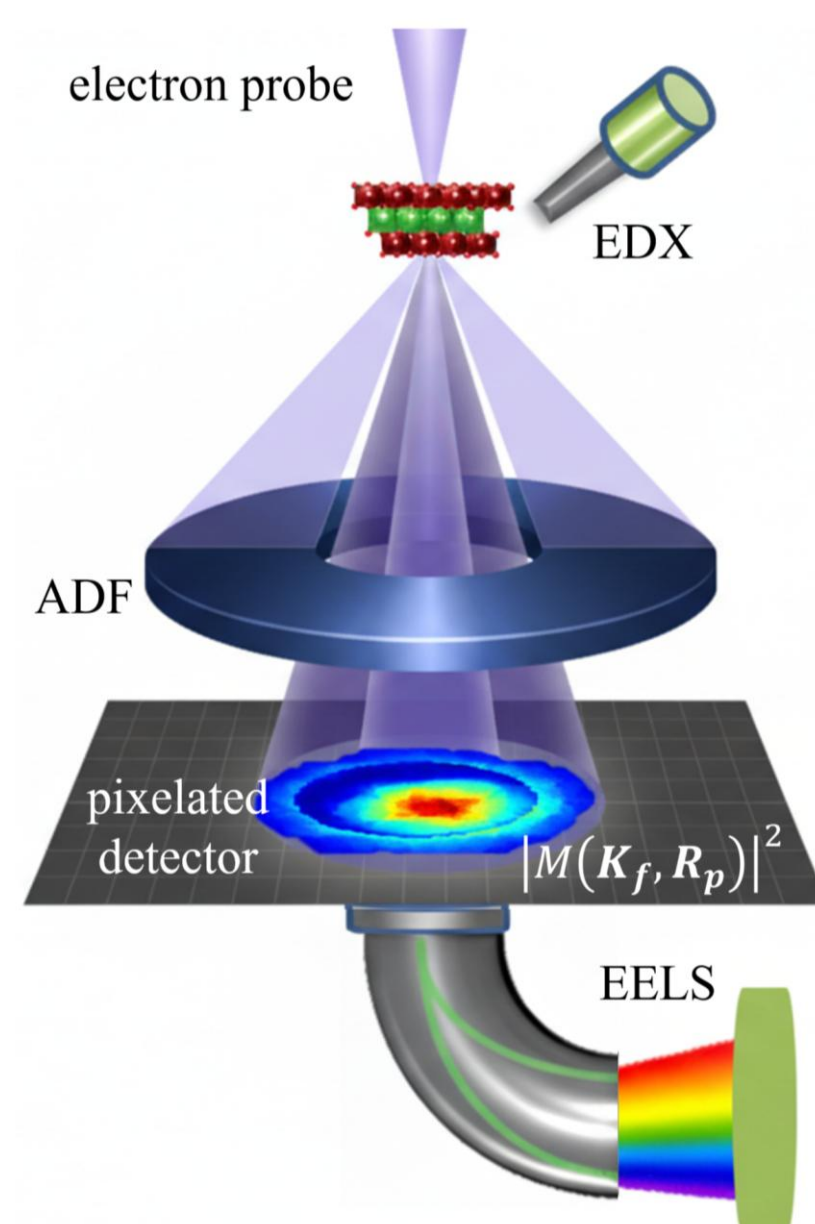


## Advanced Material Characterization

Our group has expertise in developing and applying advanced characterization methodologies to understand the materials from atomic scale and advancing material synthesis to improve device performance.

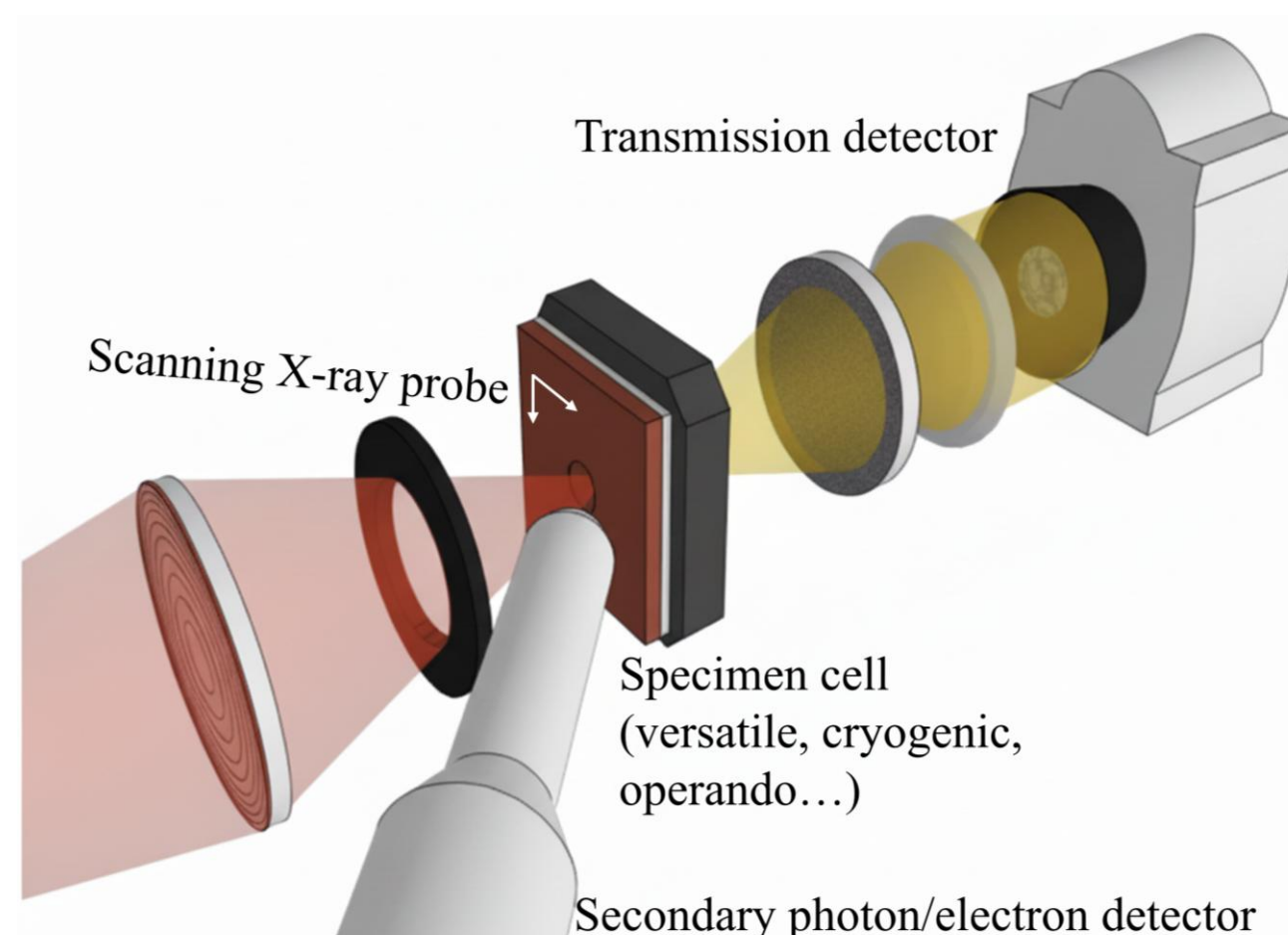
### Scanning Transmission Electron Microscopy (STEM):

- Annular Dark Field (ADF) imaging
- Electron Ptychography
- Scanning Nanobeam Electron Diffraction
- Energy dispersive X-ray Spectroscopy (EDX)
- Electron Energy Loss Spectroscopy (EELS)

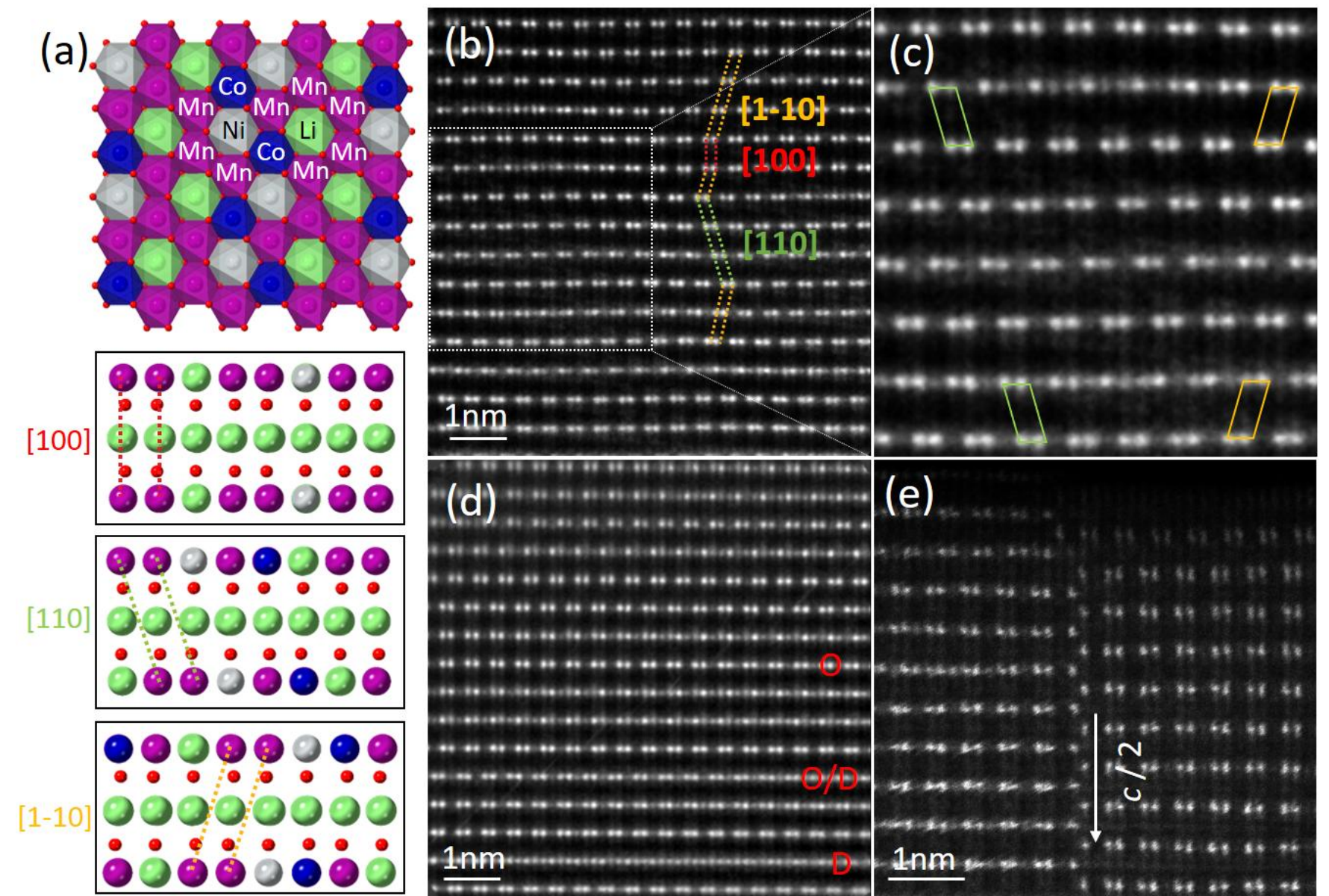


### Scanning Transmission X-ray Microscopy (STXM):

- Soft & Hard X-rays Absorption Spectroscopy (XAS)
- Transmission XAS
- Electron Yield Mode
- Fluorescence Mode

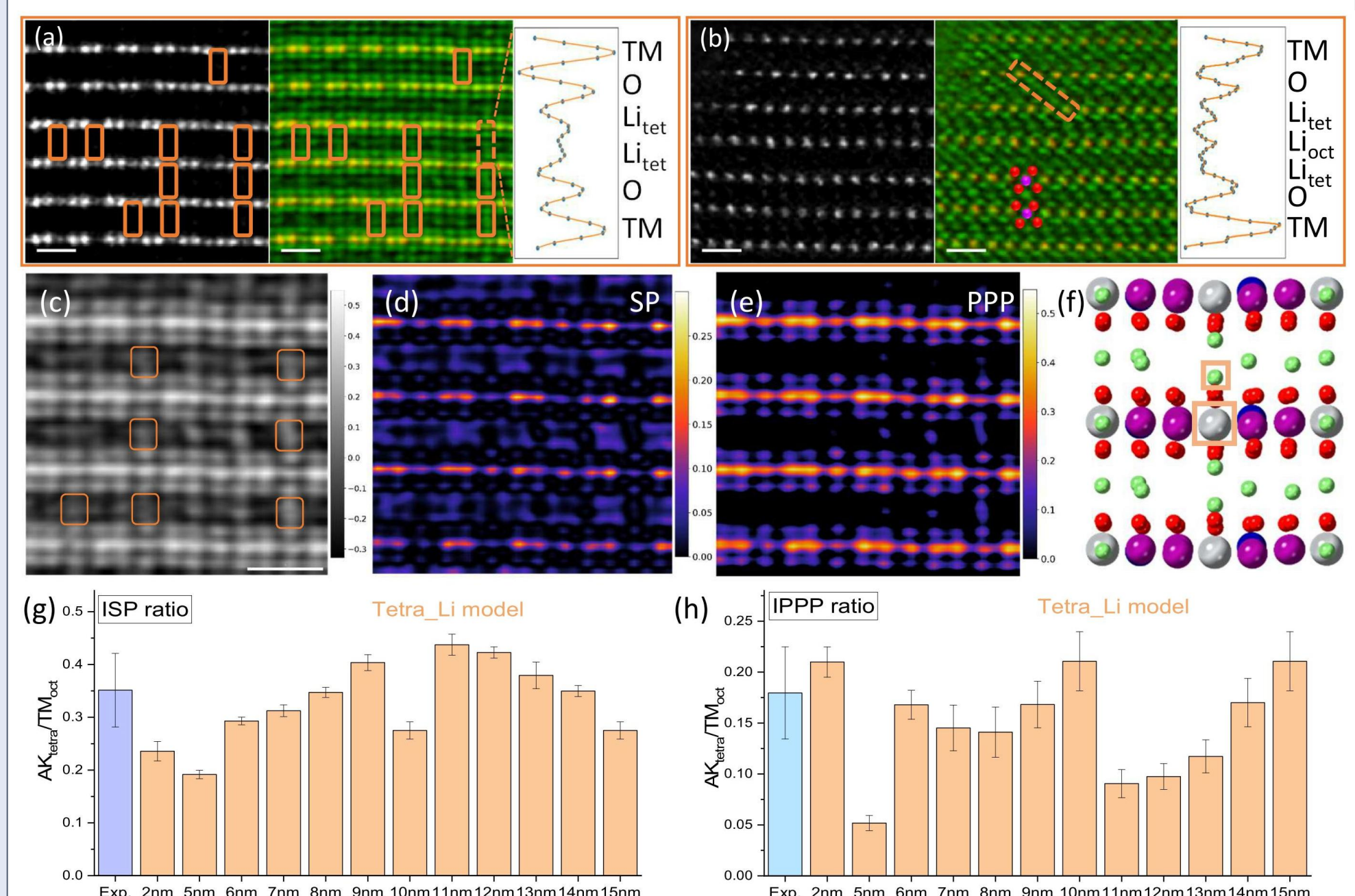


## Transition Metal (TM) Layer Stacking Faults



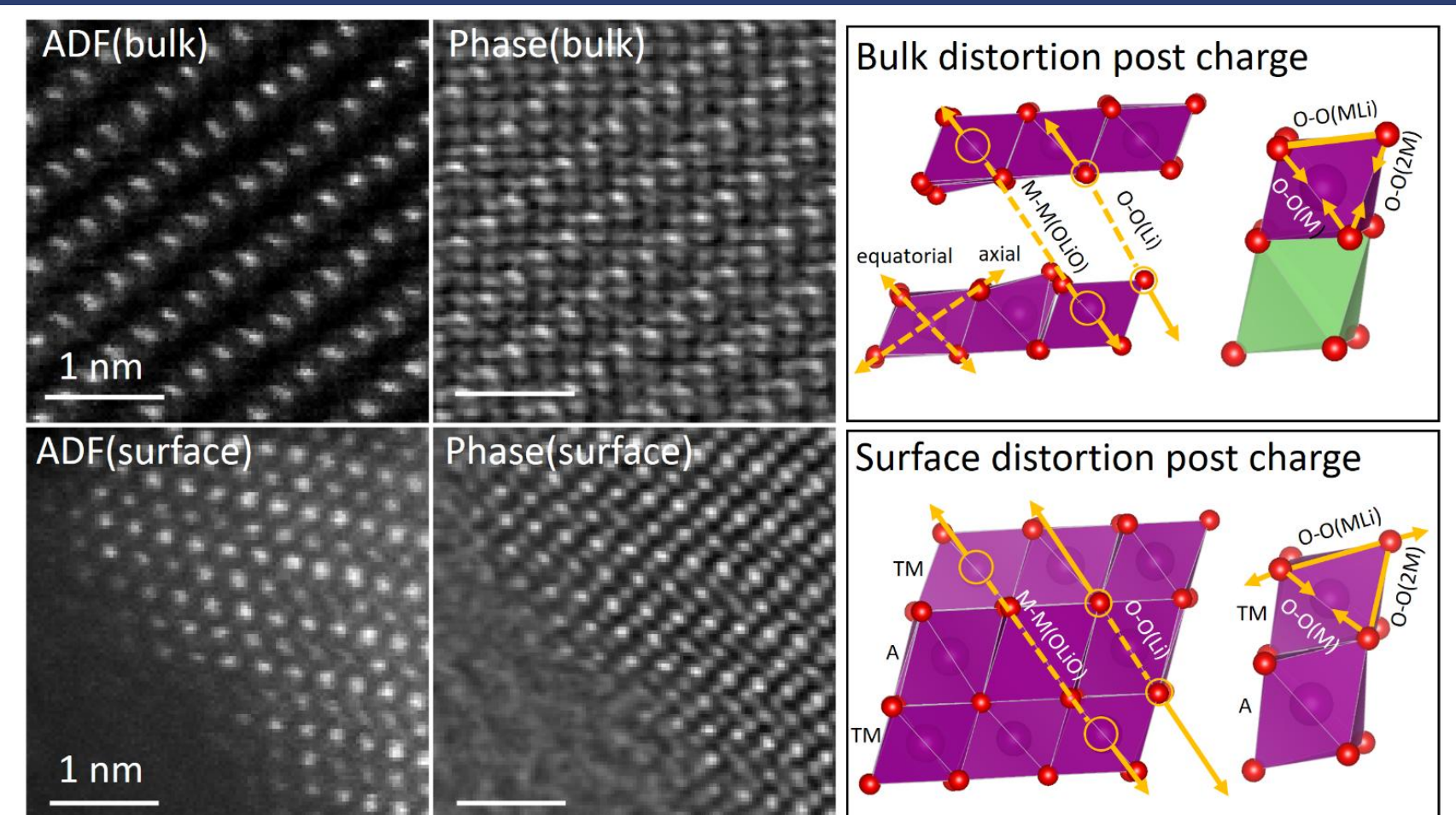
ADF imaging of  $\text{Li}_{1.2}[\text{Ni}_{0.13}\text{Mn}_{0.54}\text{Co}_{0.13}]\text{O}_2$  showing inter-layer and intra-layer stacking faults with ordered and disordered contrast.

## Lithium Diffusion Pathway



Ptychographic phase quantification demonstrates lithium diffusion from TM-layer to alkali layer through the tetrahedral sites of  $\text{Li}_{1.2}[\text{Ni}_{0.13}\text{Mn}_{0.54}\text{Co}_{0.13}]\text{O}_2$ .

## Oxygen Sublattice Distortion



Imaging of oxygen sublattice and measuring  $[\text{TMO}_6]$  octahedral distortion with pico-meter precision from bulk and surface.